

**Search Notes**

Application/Control No.

10/673,584

Examiner

Ren L. Yan

Applicant(s)/Patent under  
Reexamination

TERAE ET AL.

Art Unit

2854

**SEARCHED**

Class	Subclass	Date	Examiner
399	377 379	4/13/05	R. Yan
	380		
355	75		
	76		
358	474		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
399	380	4/15/05	R. Yan
355	76		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR